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Applicant(s) Application No. 10/772,936 OGATA ET AL. Notice of Allowability **Art Unit** Examiner 2813 Jennifer M. Dolan -- The MAILING DATE of this communication appears on the cover sheet with the correspondence address--All claims being allowable, PROSECUTION ON THE MERITS IS (OR REMAINS) CLOSED in this application. If not included herewith (or previously mailed), a Notice of Allowance (PTOL-85) or other appropriate communication will be mailed in due course. THIS NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RIGHTS. This application is subject to withdrawal from issue at the initiative of the Office or upon petition by the applicant. See 37 CFR 1.313 and MPEP 1308. 1. This communication is responsive to *Amdt of 12/28/05*. 2. The allowed claim(s) is/are 1-4. 3. Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f). b) ☐ Some* c) ☐ None 1. Certified copies of the priority documents have been received. 2. Certified copies of the priority documents have been received in Application No. 3. Copies of the certified copies of the priority documents have been received in this national stage application from the International Bureau (PCT Rule 17.2(a)). * Certified copies not received: . . . Applicant has THREE MONTHS FROM THE "MAILING DATE" of this communication to file a reply complying with the requirements noted below. Failure to timely comply will result in ABANDONMENT of this application. THIS THREE-MONTH PERIOD IS NOT EXTENDABLE. 4. A SUBSTITUTE OATH OR DECLARATION must be submitted. Note the attached EXAMINER'S AMENDMENT or NOTICE OF INFORMAL PATENT APPLICATION (PTO-152) which gives reason(s) why the oath or declaration is deficient. 5. CORRECTED DRAWINGS (as "replacement sheets") must be submitted. (a) including changes required by the Notice of Draftsperson's Patent Drawing Review (PTO-948) attached 1) hereto or 2) to Paper No./Mail Date (b) including changes required by the attached Examiner's Amendment / Comment or in the Office action of Paper No./Mail Date Identifying indicia such as the application number (see 37 CFR 1.84(c)) should be written on the drawings in the front (not the back) of each sheet. Replacement sheet(s) should be labeled as such in the header according to 37 CFR 1.121(d). 6. DEPOSIT OF and/or INFORMATION about the deposit of BIOLOGICAL MATERIAL must be submitted. Note the attached Examiner's comment regarding REQUIREMENT FOR THE DEPOSIT OF BIOLOGICAL MATERIAL. Attachment(s) 1. Notice of References Cited (PTO-892) 5. Notice of Informal Patent Application (PTO-152) 2. Notice of Draftperson's Patent Drawing Review (PTO-948) 6. Interview Summary (PTO-413). Paper No./Mail Date 3. Information Disclosure Statements (PTO-1449 or PTO/SB/08), 7. Examiner's Amendment/Comment Paper No./Mail Date 4. Examiner's Comment Regarding Requirement for Deposit 8. X Examiner's Statement of Reasons for Allowance of Biological Material 9. Other

SUPERVISORY PATENT EXAMINER
TECHNOLOGY CENTER 2800

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DETAILED ACTION

Allowable Subject Matter

- 1. Claims 1-4 are allowed.
- 2. The Examiner agrees with the Applicant's Remarks filed on 28 December 2005, and offers the following statement of reasons for allowance:

The primary reason for allowance is the limitation of performing a single imaging step, wherein both a mount portion on which a chip is to be mounted next and a portion on which a chip has just been mounted are imaged in the same visual field, and wherein the single image is used both for position detection of the chip mount portion for bonding the next chip and for inspection of the previously mounted chip.

The prior art generally teaches either the use of two separate cameras for simultaneous chip positioning and post-bonding inspection (see JP 06-132325 to Ozaki), or the use of two separate imaging steps for imaging the substrate immediately before chip positioning and for imaging the substrate for inspection immediately after chip positioning (see US 2003/0110623 to Haji et al. (particularly paragraph 0073) and US 2003/0029033 to Hidese et al). These prior art configurations suffer the disadvantages of either a late correction of bonding defects, thus leading to a large number of defective packages, in the case of using multiple simultaneous cameras (see specification of present application, pages 1-2), or very slow production of bonded packages, in the case where the same camera takes multiple images (see specification, page 2). The closest prior art of record provides no suggestion of imaging plural chip mount locations in the same field of view such that both pre-mounting positioning of a chip and post-mounting

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inspection of a previously mounted chip can be performed using a single image acquired by a single camera.

Since this configuration, as claimed by the Applicant, solves a recognized problem in the art by efficiently performing chip positioning and bonding inspection without suffering from the disadvantages of the prior art methods, and since the prior art provides no suggestion of the claimed configuration, it is the Examiner's opinion that the invention as claimed is well beyond the purview of a person having ordinary skill in the art.

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Jennifer M. Dolan whose telephone number is (571) 272-1690. The examiner can normally be reached on Monday-Friday 8:30am-5:00pm.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Carl W. Whitehead, Jr. can be reached on (571) 272-1702. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

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Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

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